## EAST Search History

| Ref<br># | Hits | Search Query                                                                                    | DBs                                                                     | Default<br>Operator | Plurals | Time Stamp          |
|----------|------|-------------------------------------------------------------------------------------------------|-------------------------------------------------------------------------|---------------------|---------|---------------------|
| Lí       | 9    | mixed signal semiconductor device and (testing circuit or device under test or unit under test) | US-PGPUB;<br>USPAT;<br>USOCR; FPRS;<br>EPO; JPO;<br>DERWENT;<br>IBM_TDB | ADJ                 | ON      | 2008/05/26<br>23:00 |
| L2       | 35   | execut\$3 and (test script\$1 same first test)                                                  | US-PGPUB;<br>USPAT;<br>USOCR; FPRS;<br>EPO; JPO;<br>DERWENT;<br>IBM_TDB | ADJ                 | ON      | 2008/05/26<br>23:00 |
| L3       | 86   | device under test interface                                                                     | US-PGPUB;<br>USPAT;<br>USOCR; FPRS;<br>EPO; JPO;<br>DERWENT;<br>IBM_TDB | ADJ                 | ON      | 2008/05/26<br>23:03 |
| L4       | 36   |                                                                                                 | US-PGPUB;<br>USPAT;<br>USOCR; FPRS;<br>EPO; JPO;<br>DERWENT;<br>IBM_TDB | ADJ                 | ON      | 2008/05/26<br>23:03 |
| L5       | 3304 |                                                                                                 | US-PGPUB;<br>USPAT;<br>USOCR; FPRS;<br>EPO; JPO;<br>DERWENT;<br>IBM_TDB | ADJ                 | ON      | 2008/05/26<br>23:03 |

| L6  | 13928 | 714/724-725,733-734,10,11,30,38,742,740,776;702/118;716/4.<br>cds. | US-PGPUB;<br>USPAT;<br>USOCR; FPRS;<br>EPO; JPO;<br>DERWENT;<br>IBM_TDB | ADJ | ON | 2008/05/26<br>23:06 |
|-----|-------|--------------------------------------------------------------------|-------------------------------------------------------------------------|-----|----|---------------------|
| L7  | 1     | mixed signal semiconductor device tester unit                      | US-PGPUB;<br>USPAT;<br>USOCR; FPRS;<br>EPO; JPO;<br>DERWENT;<br>IBM_TDB | ADJ | ON | 2008/05/26<br>23:07 |
| L8  | 1362  | test script\$1                                                     | US-PGPUB;<br>USPAT;<br>USOCR; FPRS;<br>EPO; JPO;<br>DERWENT;<br>IBM_TDB | ADJ | ON | 2008/05/26<br>23:07 |
| L9  | 23770 | single processor                                                   | US-PGPUB;<br>USPAT;<br>USOCR; FPRS;<br>EPO; JPO;<br>DERWENT;<br>IBM_TDB | ADJ | ON | 2008/05/26<br>23:08 |
| L10 | 1     | 19 and 11                                                          | US-PGPUB;<br>USPAT;<br>USOCR; FPRS;<br>EPO; JPO;<br>DERWENT;<br>IBM_TDB | ADJ | ON | 2008/05/26<br>23:08 |
| L11 | 623   | tester unit                                                        | US-PGPUB;<br>USPAT;<br>USOCR; FPRS;<br>EPO; JPO;<br>DERWENT;<br>IBM_TDB | ADJ | ON | 2008/05/26<br>23:08 |

| L12 | 1    | 111 and I4                                                         | US-PGPUB;<br>USPAT;<br>USOCR; FPRS;<br>EPO; JPO;<br>DERWENT;<br>IBM_TDB | ADJ | ON | 2008/05/26<br>23:08 |
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| L13 | 1    | 9 and  4                                                           | US-PGPUB;<br>USPAT;<br>USCCR; FPRS;<br>EPO; JPO;<br>DERWENT;<br>IBM_TDB | ADJ | ON | 2008/05/26<br>23:09 |
| L14 | 11   | execut\$3 same (first test same mixed signal semiconductor device) | US-PGPUB;<br>USPAT;<br>USOCR; FPRS;<br>EPO; JPO;<br>DERWENT;<br>IBM_TDB | ADJ | ON | 2008/05/26<br>23:09 |
| L15 | 1601 | execut\$3 same (first test)                                        | US-PGPUB;<br>USPAT;<br>USOCR; FPRS;<br>EPO; JPO;<br>DERWENT;<br>IBM_TDB | ADJ | ON | 2008/05/26<br>23:10 |
| L16 | 1    | prepar\$3 same (execution near2 second test)                       | US-PGPUB;<br>USPAT;<br>USCOR; FPRS;<br>EPO; JPO;<br>DERWENT;<br>IBM_TDB | ADJ | ON | 2008/05/26<br>23:10 |
| L17 | 1772 | prepar\$3 same ( second test)                                      | US PGPUB;<br>USPAT;<br>USOCR; FPPS;<br>EPO; JPO;<br>DERWENT;<br>IBM_TDB | ADJ | ON | 2008/05/26<br>23:11 |

| L18 | 22      | 115 and 117                                          | US-PGPUB;<br>USPAT;<br>USOCR; FPRS;<br>EPO; JPO;<br>DERWENT;<br>IBM_TDB | ADJ | ON | 2008/05/26<br>23:11 |
|-----|---------|------------------------------------------------------|-------------------------------------------------------------------------|-----|----|---------------------|
| L19 | 1       | 118 and I4                                           | US-PGPUB;<br>USPAT;<br>USOCR; FPRS;<br>EPO; JPO;<br>DERWENT;<br>IBM_TDB | ADJ | ON | 2008/05/26<br>23:11 |
| L20 | 2       | 118 and 15                                           | US-PGPUB;<br>USPAT;<br>USOCR; FPRS;<br>EPO; JPO;<br>DERWENT;<br>IBM_TDB | ADJ | ON | 2008/05/26<br>23:11 |
| L22 | 771     | device interface unit                                | US-PGPUB;<br>USPAT;<br>USOCR; FPRS;<br>EPO; JPO;<br>DERWENT;<br>IBM_TDB | ADJ | ON | 2008/05/26<br>23:24 |
| L23 | 2628696 | device under test or DUT or UUT or SUT or CUT or MUT | US-PGPUB;<br>USPAT;<br>USOCR; FPRS;<br>EPO; JPO;<br>DERWENT;<br>IBM_TDB | ADJ | ON | 2008/05/26<br>23:24 |
| L24 | 105     | device testing unit                                  | US-PGPUB;<br>USPAT;<br>USOCR; FPRS;<br>EPO; JPO;<br>DERWENT;<br>IBM_TDB | ADJ | ON | 2008/05/26<br>23:24 |

| L25 | 671141 | control unit            | US PGPUB;<br>USPAT;<br>USOCR; FPRS;<br>EPO; JPO;<br>DERWENT;<br>IBM_TDB  | ADJ | ON | 2008/05/26<br>23:24 |
|-----|--------|-------------------------|--------------------------------------------------------------------------|-----|----|---------------------|
| L26 | 280068 | operating system        | US-PGPUB;<br>USPAT;<br>USOCR; FPRS;<br>EPO; JPO;<br>DERWENT;<br>(IBM_TDB | ADJ | ON | 2008/05/26<br>23:24 |
| L27 | 466    | computational module\$1 | US PGPUB;<br>USPAT;<br>USOCR; FPRS;<br>EPO; JPO;<br>DERWENT;<br>IBM_TDB  | ADJ | ON | 2008/05/26<br>23:25 |
| L28 | 103    |                         | US PGPUB;<br>USPAT;<br>USOCR; FPRS;<br>EPO; JPO;<br>DERWENT;<br>IBM_TDB  | ADJ | ON | 2008/05/26<br>23:25 |
| L30 | 38     | 28 and  25              | US-PGPUB;<br>USPAT;<br>USOCR; FPRS;<br>EPO; JPO;<br>DERWENT;<br>IBM_TDB  | ADJ | ON | 2008/05/26<br>23:25 |
| L31 | 111    | 130 and 126             | US POPUB;<br>USPAT;<br>USCCR; FPRS;<br>EPC; JPC;<br>DERWENT;<br>IBM_TDB  | ADJ | ON | 2008/05/26<br>23:26 |

| L32 | 1 | l31 and l27 | US PGPUB;<br>USPAT;<br>USOCR; FPRS;<br>EPC; JPC;<br>DEFWENT;<br>IBM_TDB | ADJ | ON | 2008/05/26<br>23:26 |
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| L33 | 1 | 31 and  18  | US-PGPUB;<br>USPAT;<br>USOCR; FPRS;<br>EPC; JPO;<br>DERWENT;<br>(BM_TDB | ADJ | ON | 2008/05/26<br>23:26 |
| L34 | 1 | 31 and I4   | US-POPUB;<br>USPAT;<br>USCOR; FPRS;<br>EPC; JPO;<br>DERWENT;<br>(BM_TDB | ADJ | ON | 2008/05/26<br>23:27 |
| L36 | 1 | [31 and I2  | US-POPUB;<br>USPAT;<br>USOCR; FPRS;<br>EPO; JPO;<br>DEFWENT;<br>IBM_TDB | ADJ | ON | 2008/05/26<br>23:27 |
| L37 | 1 | 31 and  1   | US-PGPUB;<br>USPAT;<br>USOCR; FPRS;<br>EPO; JPO;<br>DERWENT;<br>IBM_TDB | ADJ | ON | 2008/05/26<br>23:27 |
| L39 | 1 | 131 and 18  | US POPUB;<br>USPAT;<br>USOCR; FPRS;<br>EPO; JPO;<br>DEFWENT;<br>IBM_TDB | ADJ | ON | 2008/05/26<br>23:27 |

| L40 | 2 | USPAT;<br>USOCR; FPRS;<br>EPO; JPO;<br>DERWENT;<br>IBM_TDB              |     | 2008/05/26<br>23:27 |
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| L41 |   | US-PGPUB;<br>USPAT;<br>USOCR; FPRS;<br>EPO; JPO;<br>DERWENT;<br>IBM_TDB | ADJ | 2008/05/26<br>23:27 |

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